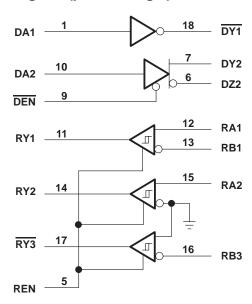
- Supports a 9-Pin GeoPort™ Host Interface Standard for the Intelligent Network Port
- Designed to Operate up to 4-Mbit/s Full **Duplex**
- ±5 V Supply Operation
- **Has Driver Short-Circuit Protection**
- **Includes Failsafe Mechanism for Open Inputs**
- Is Backward Compatible with AppleTalk™ and LocalTalk™
- **Combines Multiple Components into a Single Chip Solution**
- Complements the SN75LBC772 9-Pin GeoPort Peripheral (DCE) Interface Device
- Uses LinBiCMOS™ Process Technology

description

The SN75LBC773 is a low-power LinBiCMOS device that incorporates the drivers and receivers for a 9-pin GeoPort host interface. GeoPort combines hybrid EIA/TIA-422-B and EIA/ TIA-423-B drivers and receivers to transmit data up to four-Mbit/s full duplex. GeoPort is a serial communications standard that is intended to replace the RS-232, AppleTalk, and printer ports all in one connector in addition to providing real-time data transfer capability. SN75LBC773 provides point-to-point connections between GeoPort-compatible devices with data transmission rates up to 4-Mbit/s full duplex featuring a hot-plug capability. Applications include connection to telephone, ISDN, digital sound and imaging, fax-data modems, and other traditional serial and parallel connections. The GeoPort is backwardly compatible to both LocalTalk and AppleTalk.

DW PACKAGE (TOP VIEW) **GND** DA1 19 V_{CC} VEE [NC [18 DY1 NC [17**∏** RY3 REN [16 **∏** RB3 DZ2 15 ∏ RA2 DY2 [14 ∏RY2 GND [13 RB1 DEN 9 12 RA1 11 **∏** RY1 DA2

logic diagram (positive logic)



While the SN75LBC773 is powered off (V_{CC} and $V_{EE} = 0$), the outputs are in a high-impedance state. A logic high on the driver enable (DEN) or logic low on the receive enable (REN) terminals places the outputs of the differential driver and receivers, respectively, into a high-impedance state. All drivers and receivers have fail-safe mechanisms that ensure a high output state when the inputs are left open.

The SN75LBC773 is characterized for operation over the 0°C to 70°C temperature range.



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FUNCTION TABLES†

SINGLE-ENDED DRIVER					
INPUT (DA1)	OUTPUT (DY1)				
Н	L				
L	Н				
OPEN	L				

DIFFERENTIAL DRIVER								
INPUT	ENABLE	OUT	PUT					
(DA2)	(DEN)	(DY2)	(DZ2)					
Н	L	Н	L					
L	L	L	Н					
OPEN	L	Н	L					
Х	Н	Z	Z					
Х	OPEN	Z	Z					

SINGLED-ENDED RECEIVER								
INPUT (RA2, RA3)	ENABLE (REN)	OUTPUT (RY2) (RY3						
Н	Н	Н	L					
L	Н	L	Н					
OPEN	Н	Н	Н					
SHORT‡	Н	?	?					
Х	L	Z	Z					
X	OPEN	Z	Z					

	DIFFERENTIAL RECEIVER								
	PUT (RB1)	ENABLE (REN)	OUTPUT (RY1)						
Н	L	Н	Н						
L	Н	Н	L						
OF	PEN	Н	Н						
SHC	DRT‡	Н	?						
Х	Χ	L	Z						
Х	Χ	OPEN	Z						

[†] H = high level, L = low level, X = irrelevant, ? = indeterminate, Z = high impedance (off) $\pm -0.2 \, \text{V} < \text{V}_{\text{ID}} < 0.2 \, \text{V}$

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)§

Positive supply voltage range, V _{CC} (see Note 1)	
Negative supply voltage range, VEE (see Note 1)	–7 to 0.5 V
Receiver input voltage range (RA, RB)	–15 V to 15 V
Receiver differential input voltage range, V _{ID}	–12 V to 12 V
Receiver output voltage range (RY)	0.5 V to 5.5 V
Driver output voltage range (Power Off) (DY1, DY2, DZ2)	–15 V to 15 V
Driver output voltage range (Power On) (DY1, DY2, DZ2)	–11 V to 11 V
Driver input voltage range (DA, REN, DEN)	\dots -0.5 V to V _{CC} +0.4 V
Electrostatic Discharge (All pins) Human Body Model (see Note 2)	6 kV
Continuous total power dissipation	. See Dissipation Rating Table
Operating free-air temperature range, T _A	0°C to 70°C
Storage temperature range, T _{stq}	65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	

[§] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltage values are with respect to network ground terminal unless otherwise noted.
 - 2. This rating is per MIL-PRF-38535, Method 3015.7.



DISSIPATION RATING TABLE

PACKAGE	$\begin{array}{cc} \text{PACKAGE} & \text{$T_{A} \leq 25^{\circ}$C} \\ \text{POWER RATING} \end{array}$		T _A = 70°C POWER RATING
DW	1125 mW	9.0 mW/°C	720 mW

recommended operating conditions

	MIN	NOM	MAX	UNIT
Positive supply voltage, V _{CC}	4.75	5	5.25	V
Negative supply voltage, VEE	-5.25	-5	-4.75	V
High-level input voltage, VIH (DA, REN, DEN)	2			V
Low-level input voltage, V _{IL} (DA, REN, DEN)			0.8	V
Receiver common-mode input voltage, V _{IC}	-7		7	V
Receiver differential input voltage, V _{ID}	-12		12	V
Operating free-air temperature, T _A	0		70	°C

driver electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER		TEST CO	NDITIONS	MIN	TYP	MAX	UNIT
V	High lovel output voltage		R _L = 12 kΩ		3.6	4.5		V
Vон	High-level output voltage	Single-ended,	R _L = 120 Ω		2	3.6		V
V/01	Low-level output voltage	See Figure 1	R _L = 12 kΩ			-4.5	-3.6	V
VOL	Low-level output voltage		R _L = 120 Ω			-3.6	-2	V
IVODI	Magnitude of differential output VDY - VDZ	t voltage	R _L = 120 Ω,	See Figure 2	4			V
Δ V _{OD}	Change in differential voltage in	magnitude					250	mV
Voc	Common-mode output voltage	;			-2		2	V
l∆Voc(ss)l	Magnitude of change, common steady-state output voltage	n-mode	See Figure 3	See Figure 3			200	mV
∆VOC(PP)	Magnitude of change, common peak-to-peak output voltage	n-mode				700		mV
Icc	Positive supply current		REN = 5 V,	DEN = 0 V,		4	10	mA
I _{EE}	Negative supply current		No Load	, , , , , , , , , , , , , , , , , , ,		-2	-5	mA
Icc	Positive supply current		REN = 0 V,	DEN = 5 V,			100	μΑ
I _{EE}	Negative supply current		No Load				-100	μΑ
loz	High-impedance output curren	t	$V_{CC} = 0 \text{ or } 5 \text{ V},$	-10 ≤ V _O ≤ 10 V			±100	μΑ
los	Short-circuit output current		V _{CC} = 5.25 V, See Note 3	$-5 \text{ V} \leq \text{V}_{\text{O}} \leq 5 \text{ V},$		±170	±450	mA

NOTE 3: Not more than one output should be shorted at one time.



SN75LBC773 GEOPORT™ TRANSCEIVER

SLLS247C – FEBRUARY 1997 – NOVEMBER 1997

driver switching characteristics over operating free-air temperature range

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
^t PHL	Propagation delay time, high-to-low level output				42	75	ns
^t PLH	Propagation delay time, low-to-high level output]		41	75	ns
tPZL	Driver output enable time to low-level output		1		25	100	ns
^t PZH	Driver output enable time to high-level output]	Single ended,		25	100	ns
tPLZ	Driver output disable time from low-level output	DEN	See Figure 4		28	100	ns
^t PHZ	Driver output disable time from high-level output				37	100	ns
t _r	Rise time		1	10	25	75	ns
t _f	Fall time		1	10	23	75	ns
tPHL	Propagation delay time, high-to-low level output				40	75	ns
tPLH	Propagation delay time, low-to-high level output		1		42	75	ns
tPZL	Driver output enable time to low-level output		1		29	150	ns
^t PZH	Driver output enable time to high-level output	DEN .	Differential,		35	150	ns
tPLZ	Driver output disable time from low-level output	DEN	See Figure 5		34	100	ns
tPHZ	Driver output disable time from high-level output	1			34	100	ns
t _r	Rise time]	10	27	75	ns
t _f	Fall time			10	26	75	ns
tSK(p)	Pulse skew, tpLH - tpHL					22	ns

SLLS247C - FEBRUARY 1997 - NOVEMBER 1997

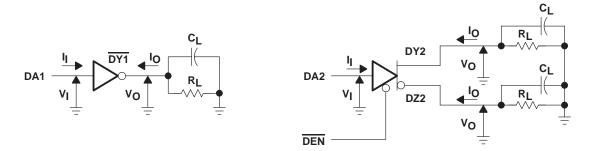
receiver electrical characteristics over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST COM	MIN	TYP	MAX	UNIT	
V _{IT+}	Positive-going input threshold voltage					200	mV
V _{IT} _	Negative-going input threshold voltage	See Figure 6		-200			mV
V _{hys}	Differential input voltage hysteresis (V _{IT+} – V _{IT-})				50		mV
VOH	High-level output voltage (see Note 4)	V _{IC} = 0, See Figure 6	$I_{OH} = -2 \text{ mA},$	2	4.5		V
VOL	Low-level output voltage	V _{IC} = 0, See Figure 6	$I_{OL} = 2 \text{ mA},$		0.4	0.8	V
laa	Short aircuit autaut aurrant	V _O = 0			-45	-85	mA
los	Short-circuit output current	V _O = 5.25 V			45	85	mA
R _{IN}	Input resistance	$V_{CC} = 0 \text{ or } 5.25 \text{ V},$	$-12 \text{ V} \le \text{V}_{I} \le 12 \text{ V}$	6	30		kΩ

NOTE 4: If the inputs are left unconnected, receivers one and two interpret this as a high-level input and receiver three interprets this as a low-level input so that all outputs are at the high level.

receiver switching characteristics over recommended conditions (unless otherwise noted)

	PARAMETER		TEST CO	NDITIONS	MIN	TYP	MAX	UNIT
tPHL	Propagation delay time, high-to-low level output					30	75	ns
tPLH	Propagation delay time, low-to-high level output		$R_L = 2 k\Omega$,	C _L = 15 pF,		30	75	ns
t _r	Rise time		See Figure 6	_		15	30	ns
t _f	Fall time					15	30	ns
tSK(P)	Pulse skew tpLH-tpHL						20	ns
tPZL	Receiver output enable time to low-level output					35	100	ns
tPZH	Receiver output enable time to high-level output	1				35	100	ns
tPLZ	Receiver output disable time from low-level output	Differential				20	100	ns
^t PHZ	Receiver output disable time from high-level output			Coo Figure 7		20	100	ns
tPZL	Receiver output enable time to low-level output		$C_L = 50 \text{ pF},$	See Figure 7		12	25	μs
^t PZH	Receiver output enable time to high-level output	1				12	25	μs
tPLZ	Receiver output disable time from low-level output	Single-ended				25	100	ns
^t PHZ	Receiver output disable time from high-level output			Î		125	400	ns



NOTE A: C_L = 50 pF

Figure 1. Single-Ended Driver DC Parameter Test Circuits

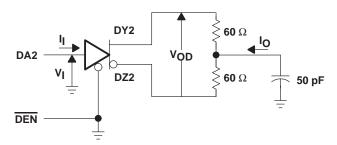
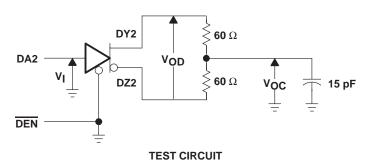
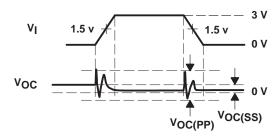


Figure 2. Differential Driver DC Parameter Test Circuit



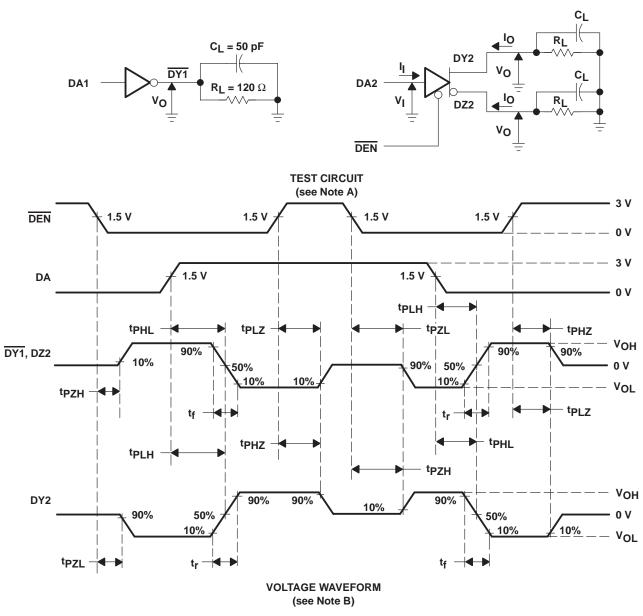


VOLTAGE WAVEFORM

NOTE A: Measured 3dB Bandwidth = 300 MHz

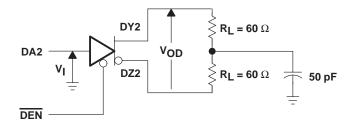
Figure 3. Differential Driver Common-Mode Output Voltage Test Circuit



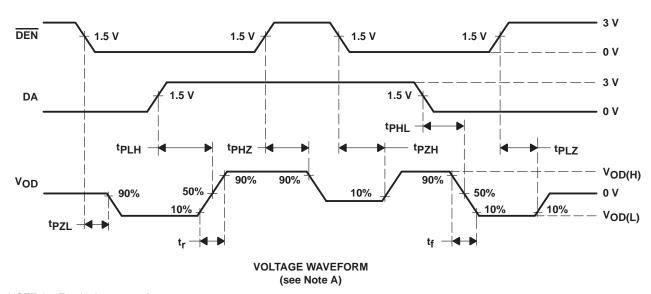


NOTES: A. $C_L = 50$ pF, $R_L = 120$ Ω B. The input waveform t_r , $t_f \le 10$ ns.

Figure 4. Single-Ended Driver Propagation and Transition Times Test Circuits and Waveform

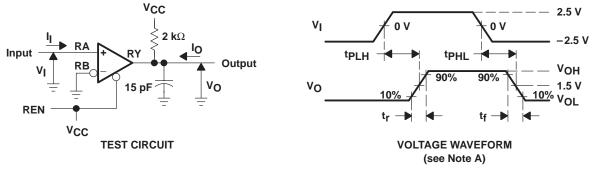


TEST CIRCUIT



NOTE A: For the input waveform t_f , $t_f < = 10$ ns

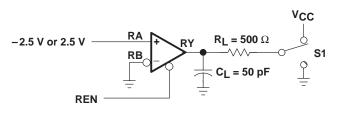
Figure 5. Differential Driver Propagation and Transition Times Test Circuit and Waveforms



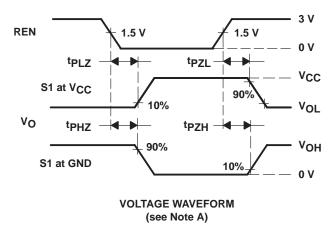
NOTE A: For the input waveform t_r , $t_f < = 10$ ns

Figure 6. Receiver Propagation and Transition Times Test Circuit and Waveform





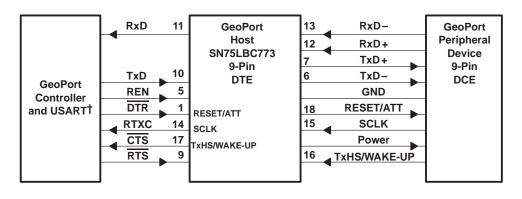
TEST CIRCUIT

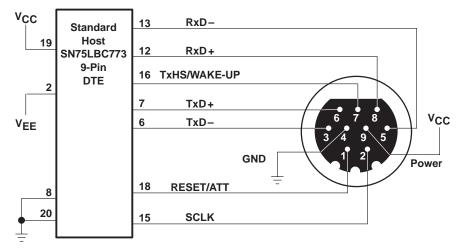


NOTE A: For the input waveform t_r , $t_f < = 10$ ns

Figure 7. Receiver Enable and Disable Test Circuit and Waveforms

APPLICATION INFORMATION





 $[\]dagger$ USART = universal synchronous asynchronous receiver transmitter

Figure 8. GeoPort 9-Pin DTE Connection Application

generator characteristics

PARAMETER		TEST	TEST CONDITIONS		232/V.28		423/V.10		562	
		l lesi c	CNDITIONS	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
		Open circuit			25	4	6		13.2	V
IVOI	Output voltage magnitude	$3 \text{ k}\Omega \leq \text{RL} \leq 7$	7 kΩ	5	15	NA		3.7		V
		$R_L = 450 \Omega$		NA		3.6		NA		V
Ios	Short-circuit output current	V _O = 0			100		150		60	mA
R(OFF)	Power-off source resistance	$V_{CC} = 0$,	VO < 2 V	300		NA		300		Ω
I _{O(OFF)}	Power-off output current	$V_{CC} = 0$,	VO < 6 V	NA			±100	NA		μΑ
SR	Output voltage slew rate				30	NA		4	30	V/μs
		±3.3 V to ±3.3	3 V	NA		NA		0.22	2.1	μs
t _t	Output transition time	±3 V to ±3 V			0.04	NA		NA		ui‡
		10% to 90%	·	NA			0.3	NA		ui‡
VO(RING)	Output voltage ring		·	NA			10%		5%	

[‡] ui is the unit interval and is the inverse of the signaling rate (bit time).



SLLS247C - FEBRUARY 1997 - NOVEMBER 1997

APPLICATION INFORMATION

receiver characteristics

PARAMETER		TEST CONDITIONS	232/V.28		423/V.10		562		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	UNIT
V _I	Input voltage			25		10		25	V
VIT	Input voltage threshold	V _I < 15 V	-3	3	NA		-3	3	V
		V _I < 10 V	NA		-0.2	0.2	NA		V
RĮ	Input resistance	3 V < V _I < 15 V	3	7	NA		3	7	kΩ
		V _I < 10 V	NA		4		NA		kΩ

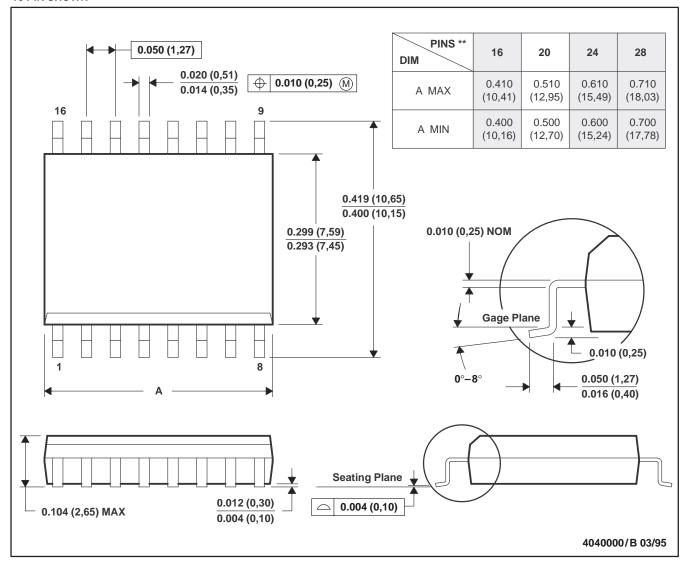
SLLS247C - FEBRUARY 1997 - NOVEMBER 1997

MECHANICAL INFORMATION

DW (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

16 PIN SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013

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